

<b>Notice of References Cited</b>	Application/Control No. 10/735,612	Applicant(s)/Patent Under Reexamination CHIEN, HIGHLY	
	Examiner CongVan Tran	Art Unit 2683	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,987,119 a	11-1999	Lee, Seog-Geun	379/379
	B	US-4,922,529	05-1990	Kiel, David J.	379/377
	C	US-5,317,626 A	05-1994	Jaynes et al.	379/67.1
	D	US-4,481,382	11-1984	Villa-Real, Antony-Euclid C.	455/556.1
	E	US-6,850,601 B2	02-2005	Jones et al.	379/45
	F	US-5,317,626	05-1994	Jaynes et al.	379/67.1
	G	US-6,262,657	07-2001	Okuda et al.	340/439
	H	US-6,674,358	01-2004	Tinsley, Keith R.	340/7.63
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.